

# N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)			
20	0.0116 at V <sub>GS</sub> = 4.5 V	12			
20	0.0129 at V <sub>GS</sub> = 2.5 V	8			

#### **FEATURES**

TrenchFET<sup>®</sup> Power MOSFET

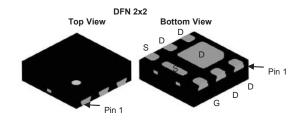
ESD Protected: 4000 V

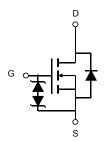
Common Drain



#### **APPLICATIONS**

• 1-2 Cell Battery Protection Circuitry





ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C)  Parameter  Drain-Source Voltage		Symbol Limit		Unit	
		V <sub>DS</sub>	20		
Gate-Source Voltage		V <sub>GS</sub>	± 12		
	T <sub>C</sub> = 25 °C		12 <sup>a</sup>		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C		10 <sup>a</sup>		
Continuous Brain Current (1) = 130 C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub> -	12 <sup>a, b, c</sup>		
	T <sub>A</sub> = 70 °C		9.1 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	40		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		12 <sup>a</sup>		
Continuous Source-Diam Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	2.9 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		19.2		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	12.3	w	
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	] 'D [	3.5 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		2.2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	28	36	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	5.3	6.5	C/ <b>VV</b>	

#### Notes:

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. The DFN2X2 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80  $^{\circ}\text{C/W}.$

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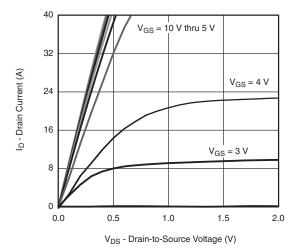
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250  \mu\text{A}$	20			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		24		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1D = 200 μπ		- 5.6			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$			3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 5	μA	
Zava Cata Valta va Duais Courset	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			1		
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	20			Α	
	В	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 7 A		0.0116	0.0128		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 2.5 \text{ V}, I_D = 5 \text{ A}$		0.0129	0.0142	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7 A		16		S	
Dynamic <sup>b</sup>	'						
Input Capacitance	C <sub>iss</sub>			800		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		200			
Reverse Transfer Capacitance	C <sub>rss</sub>			90			
· ·	100	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 12 \text{ A}$		12	18		
Total Gate Charge	Q <sub>g</sub>		5.3	9			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 2.5 \text{ V}, I_{D} = 12 \text{ A}$		2		nC	
Gate-Drain Charge	Q <sub>gd</sub>			1.4			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		2.5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			16	25		
Rise Time	t <sub>r</sub>	V 40V D 40		10	15	- - -	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 10 \text{ V}, R_L = 1 \Omega$ $I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		15	25		
Fall Time	t <sub>f</sub>	ID = IOA, VGEN - 4.5 V, IIg - 1.52		10	15		
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 10 \text{ V}, R_L = 1 \Omega$		8	15	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{D} \cong 10 \text{ A}, V_{GEN} = 2.5 \text{ V}, R_{q} = 1 \Omega$		17	30		
Fall Time	t <sub>f</sub>	B = 1071, TGEN = 10 1, 1.1g		8	15		
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			12	۸	
Pulse Diode Forward Current	I <sub>SM</sub>				40	A	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			18	30	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 10 A dl/dt = 100 A/vo T = 05 °C		7	15	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		8		,	
Reverse Recovery Rise Time	t <sub>b</sub>	7		10		ns	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

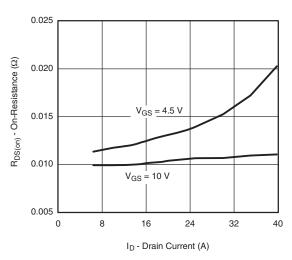
Notes: a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.



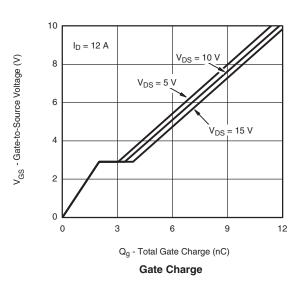
### TYPICAL CHARACTERISTIC (25 °C, unless otherwise noted)

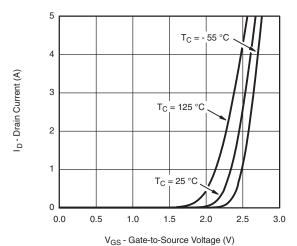


### **Output Characteristics**

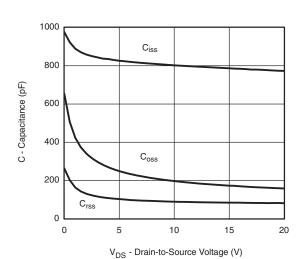


On-Resistance vs. Drain Current and Gate Voltage

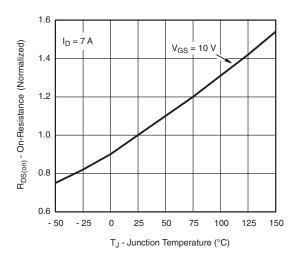




**Transfer Characteristics** 



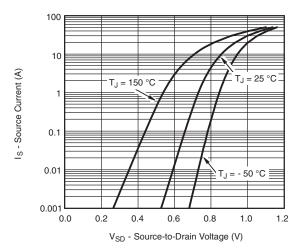
Capacitance



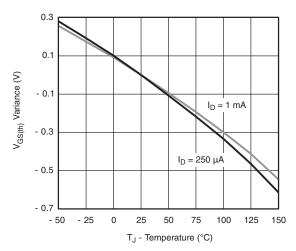
On-Resistance vs. Junction Temperature



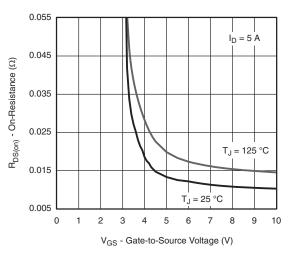
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



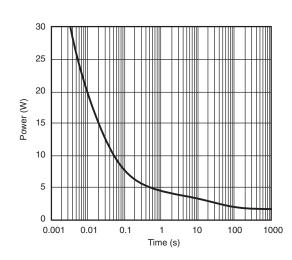
#### Source-Drain Diode Forward Voltage



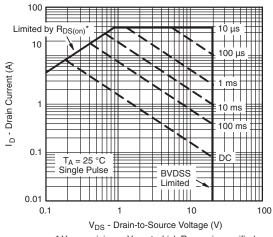
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power (Junction-to-Ambient)

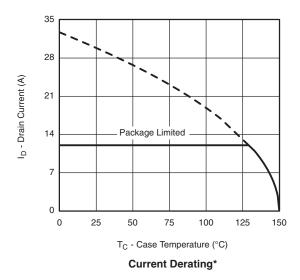


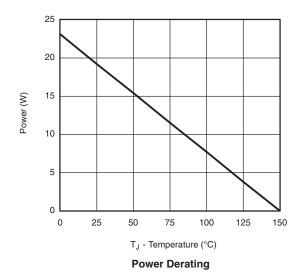
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

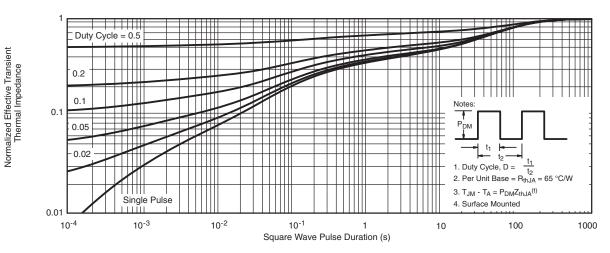




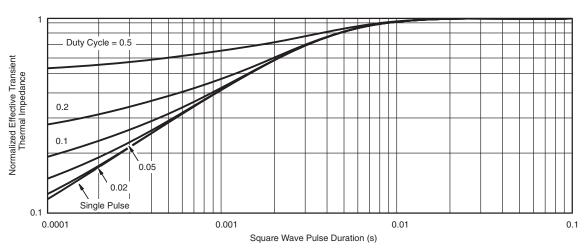
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

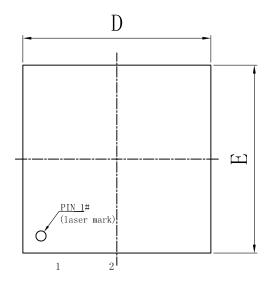


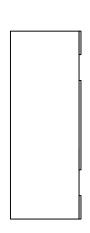
Normalized Thermal Transient Impedance, Junction-to-Ambient

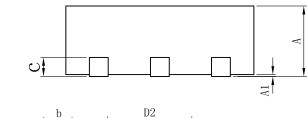


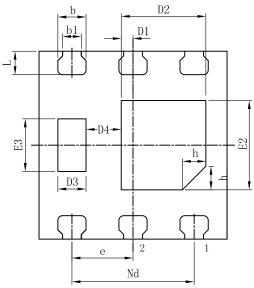
Normalized Thermal Transient Impedance, Junction-to-Case











BOTTOM VIEW

SYMBOL	MILLIMETER			
STMBOL	MIN	NOM	MAX	
A	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
b	0. 25	0.30	0.35	
b1	0. 20REF			
с	0.203REF			
D	1.90	2.00	2. 10	
D1	0.08	0. 125	0. 18	
D2	0.85	0.90	0. 95	
D3	0. 25	0.30	0. 35	
D4	0. 33	0. 375	0. 43	
e	0. 65BSC			
Nd	1. 30BSC			
Е	1.90	2.00	2. 10	
E2	0. 90	0. 95	1.00	
E3	0. 51	0.56	0.61	
L	0. 20	0.25	0.30	
h	0. 25REF			



# Din-Tek SEMICONDUCTOR

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